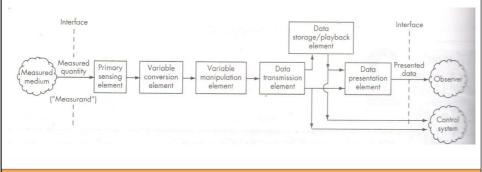
Elements of an Instrument



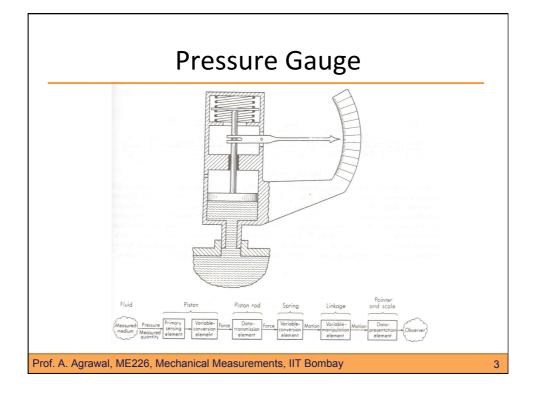
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Functional Elements of an Instrument

- Operation characteristics of an instrument can be described by its static and dynamic performance characteristics
- If one tries to generalize the functional elements of an instrument or measurement system, we have



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Functional Elements of an Instrument

(contd.)

- <u>Primary Sensing Element</u>: First element which receives energy from the measured medium and produces an output (in some manner)
- <u>Variable Conversion Element</u>: Convert the output of the primary sensing element to a more suitable variable (eg. Motion converted to voltage)
- <u>Variable Manipulation Element</u>: May involve amplification or some other manipulation of the signal
- <u>Data Transmission Element</u>: It is usually necessary to transmit the data from one to the next block

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Functional Elements of an Instrument

(contd.)

 <u>Data Presentation Element</u>: Information put in form understood by humans (eg. Pointer on a scale; Pen moving on a chart)

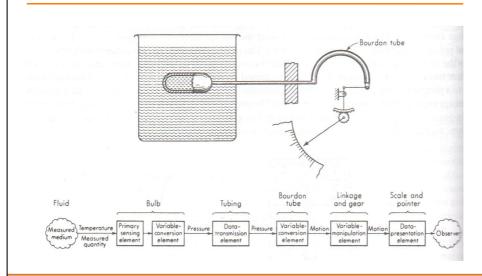
Notes:

- 1) Concept of various *functional* elements (and **not** *physical* elements) is presented above
- 2) A *physical* element may perform tasks of more than one *functional* element
- 3) The order in which blocks are arranged may change between instruments

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Pressure Thermometer



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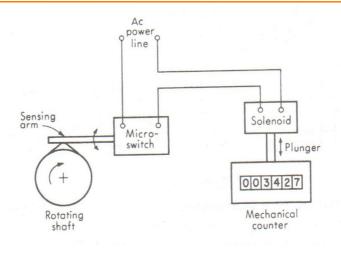
Active and Passive Transducers

- <u>Transducer</u>: Input and output of different energy types. So transducer is a device involving energy conversion (mechanical to electrical, for example)
- <u>Passive Transducer</u>: A component whose output energy is supplied entirely (or almost entirely) by its input signal is called a passive transducer
- Active Transducer: Has an auxiliary source of power supplying a major part of the output power (input signal supplies only an insignificant portion of power)
 (Digital revolution counter is an active device)

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Digital Revolution Counter



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Analog and Digital Modes of Operation

- Analog signal: The precise value of the quantity (voltage, rotation angle, etc) carrying the information is significant
- <u>Digital signal</u>: Basically binary (ON/OFF) type

Typically, +2 to +5 V : ON state 0 to +0.8 V : OFF state

<u>Note</u>: Both 2.5 and 3 V have the same meaning in digital signal (ON state) but different meaning if signal is analog. So digital signals more tolerant to "noise".

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Analog and Digital Modes of Operation

(contd.)

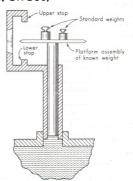
- A measurement system may have combined analog/digit systems
- Majority of primary sensing elements are of analog type
- Digital revolution counter is however of digital type
- Importance of digital instruments is increasing because digital computers are used in data-reduction and automatic control systems
- Most measurement systems have "analog-to-digital convertors" (input to computer) and/or "digital-to-analog convertors" (output from computer)

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Null and Deflection Methods

- In a deflection type device, the measured quantity produces an effect
- In contrast, in a null type device, deflection is maintained zero (by application of a suitable opposing effect)





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Comparison of Null and Deflection Methods

- Comparing pressure gauges, note that accuracy of pressure gauge with spring (deflection type gauge) depends on calibration of spring; for deadweight pressure gauge (null type gauge), accuracy depends on standard weights. So accuracy higher in the latter case.
- In general, <u>higher</u> accuracy attained with null-type gauges. (Spring has to be calibrated against some standard. Whereas, in null type, direct comparison against standard is possible.)
- Also, high sensitivity to any deflection around zero can be achieved (since smaller range is to be covered)
- The detector need not be calibrated (since it has to detect only presence or direction of unbalance)

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Calibration of Instruments

- How much deflection corresponds to how much pressure for the pressure gauge (in slide 3)?
- How much deflection corresponds to how much temperature for the pressure thermometer (in slide 6)?
- · Need of calibration
- You can use null type instrument to calibrate deflection type instrument

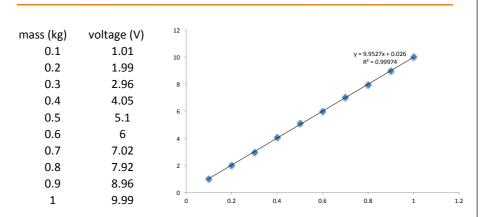




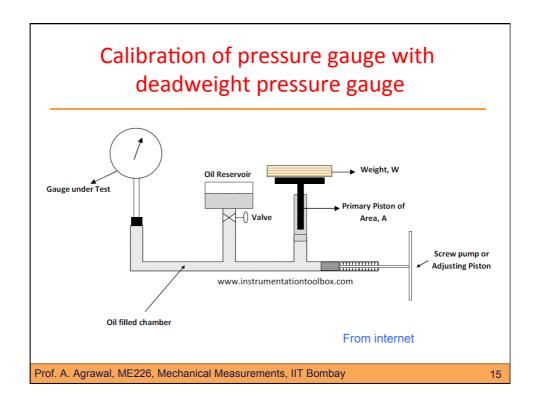
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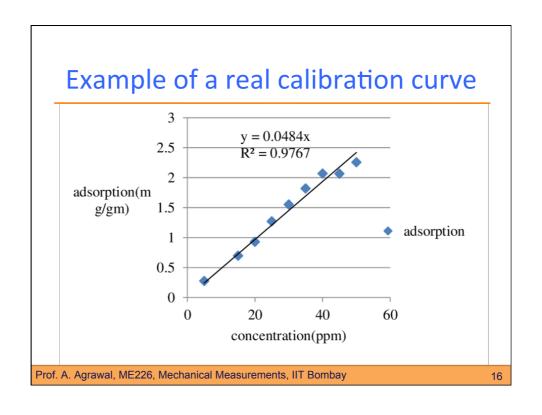
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Example of Calibration



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Input-Output Configuration of Instruments

Input quantities can be: desired, interfering or modified inputs

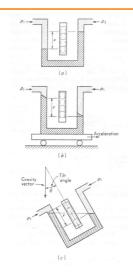
- <u>Desired inputs</u>: Quantities that the instrument is designed to measure
- <u>Interfering inputs</u>: Quantities to which the instrument is unintentionally sensitive
- Modifying inputs: Quantities that cause change in the inputoutput relations for the desired and interfering inputs. (Note: may affect both desired and interfering inputs.)

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Generalized Input-Output Configuration Output component due to interfering input and im Interfering input $F_{M,I}$ Modifying input Output FM, D T = 25 V + 30Where T is temperature (°C); V is voltage (V) Desired input Fo Output component due to desired input and im Prof. A. Agrawal, ME226, Mechanical Measurements, IIT Bombay 18

Spurious Inputs for Manometer



- Interfering input for manometer: acceleration
- Modifying inputs for manometer include ambient temperature (changes length of the calibration scale; density of mercury) and gravitational force (due to change in latitude/ altitude of the manometer)

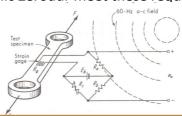
 these factors change the proportionality factor

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Methods of Correction for Interfering and Modifying Inputs

- Method of inherent insensitivity: Make the instrument inherently sensitive only to the desired inputs. That is, make F_i and $F_{M,D}$ (see **Generalized Input-Output Configuration** slide) as close to zero as possible. Thus, even when i_i and/or i_M exist, they do not affect the output.
- <u>Eg.</u> Strain gauge with very low temperature coefficient of resistance, but very high sensitive to strain (metal alloy Invar and glass/ceramic Zerodur meet these requirements)



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Methods of Correction for Interfering and Modifying Inputs (contd.)

- Method of calculated output corrections: requires measurement/ estimation of the magnitudes of interfering and/or modifying inputs and to know quantitatively how they affect the output
- That is, estimate the amount of correction and subtract from the indicated output
- Eg. For manometer, effect of temperature on scale's length and density of mercury is known and can be corrected
- Similarly, change in value of 'g' with location can be accounted for
- Some of these corrections can be done on-board using smart sensors

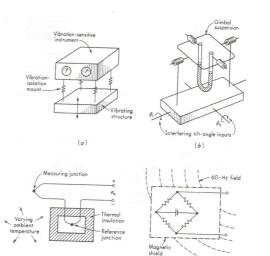
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Methods of Correction for Interfering and Modifying Inputs

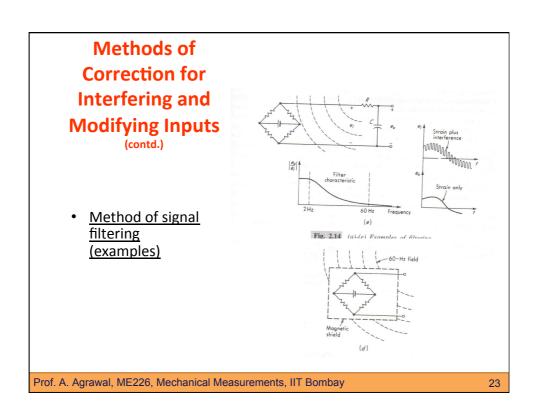
• <u>Method of signal</u> filtering

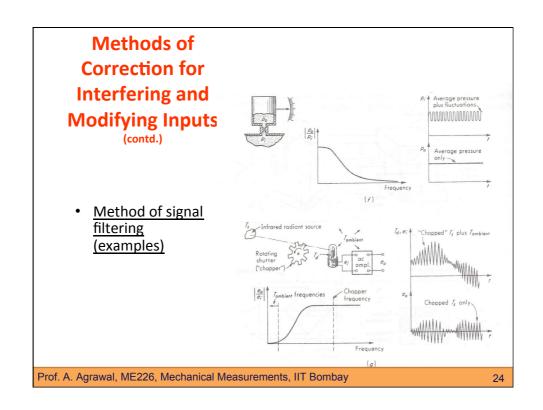
(examples)

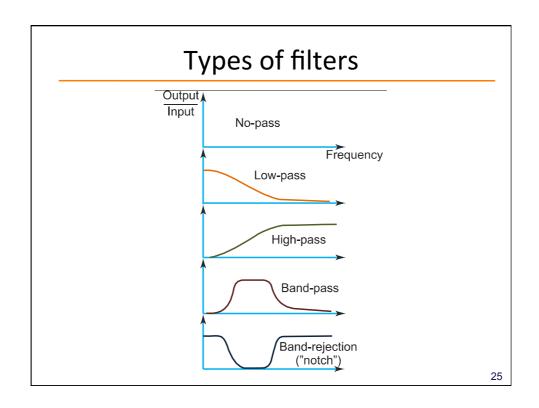


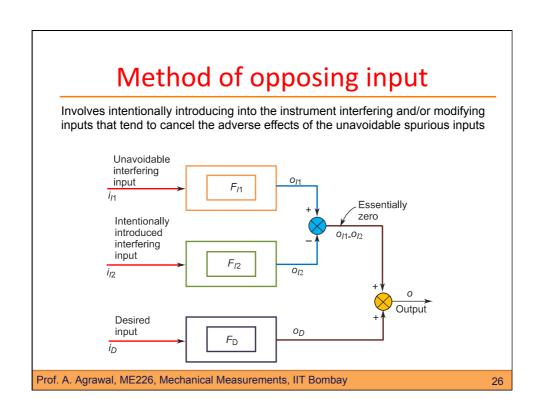
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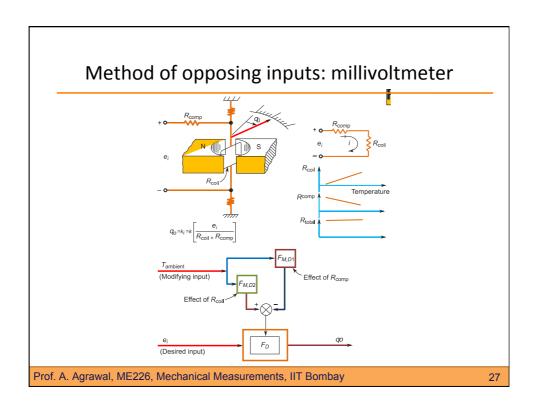
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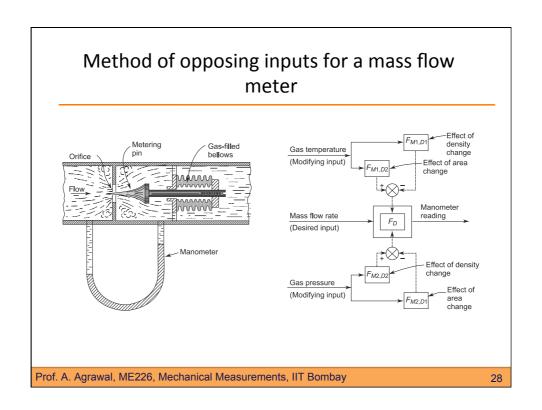




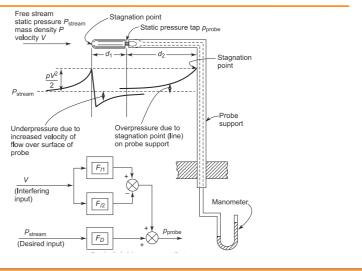








Example of method of opposing inputs for a static-pressure probe



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Homework

- Pick any instrument. Find out its working principle, and identify the various functional blocks therein.
- Also, identify at least two interfering and two modifying inputs for the chosen instrument.

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